

SEMITOP® 3

Boost Chopper

SK120GAL12F4T

Features*

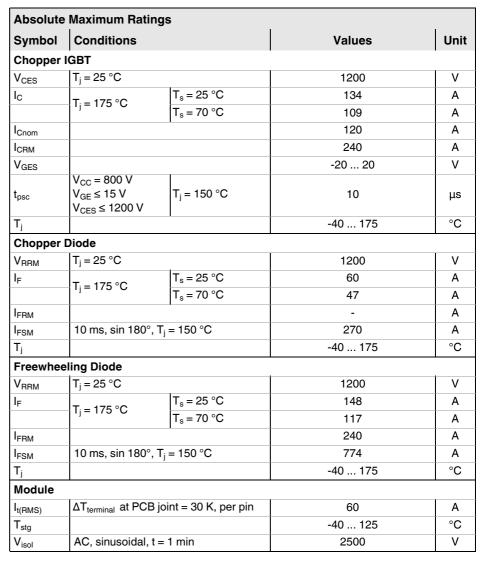
- One screw mounting module
- · Low inductive design
- · Heat transfer and insulation through
- direct copper bonded aluminum oxide ceramic (DBC)
- 1200V Trench4 IGBT (F4)
- Robust and soft switching freewheeling diode CAL4F
- Integrated NTC temperature sensor
- UL recognized, file no. E 63 532

Typical Applications

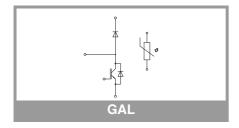
- Solar
- UPS
- · Energy Storage Systems

Remarks

Chopper Diode: antiparallel diode



Characteristics									
Symbol	Conditions	min.	typ.	max.	Unit				
Chopper	IGBT		•			•			
V _{CE(sat)}	$I_C = 120 \text{ A}$ $V_{GE} = 15 \text{ V}$ chiplevel	T _j = 25 °C		2.05	2.4	V			
		T _j = 150 °C		2.59	2.85	V			
V _{CE0}	chiplevel	T _j = 25 °C		0.80	0.90	V			
		T _j = 150 °C		0.70	0.80	V			
r _{CE}	V _{GE} = 15 V chiplevel	T _j = 25 °C		10	13	mΩ			
		T _j = 150 °C		16	17	mΩ			
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 4.5$ mA		5.2	5.8	6.4	V			
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}, T_j = 25 ^{\circ}\text{C}$			-	1.6	mA			
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		6.9		nF			
Coes		f = 1 MHz		0.555		nF			
C _{res}		f = 1 MHz		0.405		nF			
Q_{G}	V _{GE} = - 15 V+ 15 V			840		nC			
R _{Gint}	T _j = 25 °C		1.6		Ω				





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• Solar

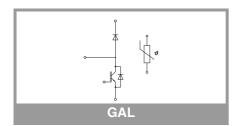
• UPS

• Energy Storage Systems

Remarks

• Chopper Diode: antiparallel diode

Characteristics										
Symbol	Conditions		min.	typ.	max.	Unit				
Chopper I										
t _{d(on)}	V _{CC} = 600 V	T _i = 150 °C		98		ns				
t _r	I _C = 120 A	T _i = 150 °C		31		ns				
E _{on}	$R_{G \text{ on}} = 1.5 \Omega$	T _i = 150 °C		13.9		mJ				
t _{d(off)}	$R_{G \text{ off}} = 1.5 \Omega$ $di/dt_{on} = 3200 \text{ A/µs}$,	306			ns				
t _f	$di/dt_{off} = 1900 \text{ A/}\mu\text{s}$	T _i = 150 °C		46		ns				
E _{off}	$V_{GE} = +15/-15 \text{ V}$ $dv/dt = 1990 \text{ V/}\mu\text{s}$	T _j = 150 °C	9			mJ				
R _{th(j-s)}	per IGBT, λ _{paste} =0.8 W/(mK)		0.35			K/W				
Chopper Diode										
$V_F = V_{EC}$	I _F = 13 A	T _i = 25 °C		0.97	1.20	V				
	chiplevel	T _j = 150 °C		0.84	1.07	V				
V _{F0}	chiplevel	T _i = 25 °C		0.89	1.09	V				
		T _i = 150 °C		0.73	0.92	V				
r _F	chiplevel	T _i = 25 °C		6.2	8.5	mΩ				
		T _j = 150 °C		8.8	12	mΩ				
I _{RRM}	I _F = 13 A			-		Α				
Q _{rr}				-		μС				
E _{rr}				-		mJ				
R _{th(j-s)}	per Diode, λ _{paste} =0.	8 W/(mK)		1.5		K/W				
	ling Diode					1				
$V_F = V_{EC}$	I _F = 150 A	T _j = 25 °C		2.17	2.49	V				
	chiplevel	T _j = 150 °C		2.11	2.42	V				
V_{F0}	chiplevel	T _j = 25 °C		1.30	1.50	V				
	Chipievei	T _j = 150 °C		0.90	1.10	V				
r _F	chiplevel	T _j = 25 °C		5.8	6.6	mΩ				
		T _j = 150 °C		8.1	8.8	mΩ				
I _{RRM}	I _F = 120 A	T _j = 150 °C		112		Α				
Q _{rr}	$di/dt_{off} = 3200 \text{ A/}\mu\text{s}$	T _j = 150 °C		21		μС				
E _{rr}	√V _{GE} = -15 V V _R = 600 V	T _j = 150 °C		7.7		mJ				
R _{th(j-s)}	per Diode, $\lambda_{paste}=0$.	8 W/(mK)		0.45		K/W				
Module	1									
L _{CE}				-		nΗ				
R _{CC'+EE'}		T _s = 25 °C		-		mΩ				
		T _s = 150 °C		-		mΩ				
Ms	to heatsink		2.25		2.5	Nm				
Mt				-		Nm				
				-		Nm				
w				29		g				
	ure Sensor									
R ₁₀₀	T _c =100°C (R ₂₅ =5 k		493 ± 5%		Ω					
B _{100/125}	$R_{(T)} = R_{100} exp[B_{100/125}(1/T-1/T_{100})]; T[K];$		3550 ±2%			К				



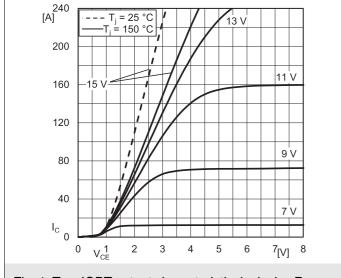


Fig. 1: Typ. IGBT output characteristic, inclusive R_{CC'+ EE'}

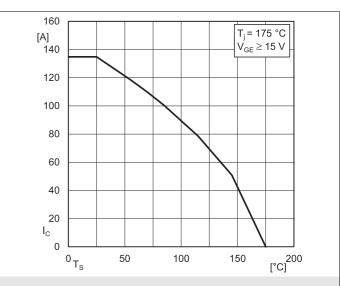


Fig. 2: IGBT rated current vs. temperature I_c=f(T_s)

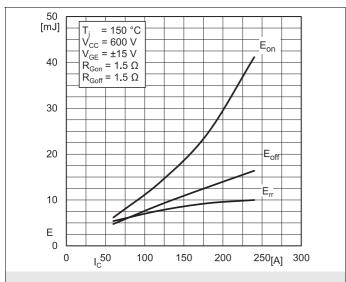


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

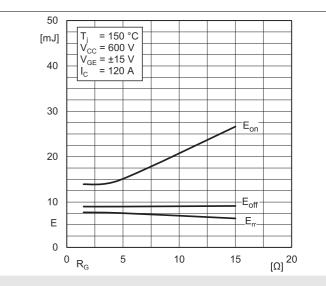


Fig. 4: Typ. turn-on /-off energy = f (R_G)

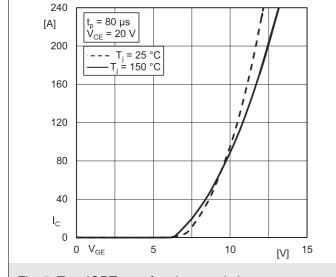


Fig. 5: Typ. IGBT transfer characteristic

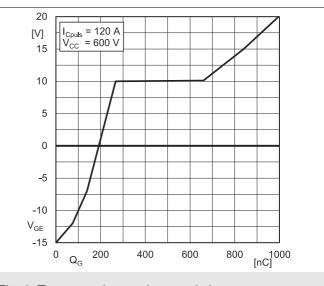


Fig. 6: Typ. gate charge characteristic

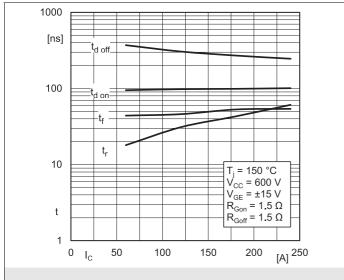


Fig. 7: Typ. switching times vs. I_C

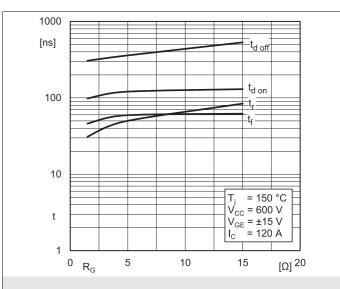


Fig. 8: Typ. switching times vs. gate resistor R_G

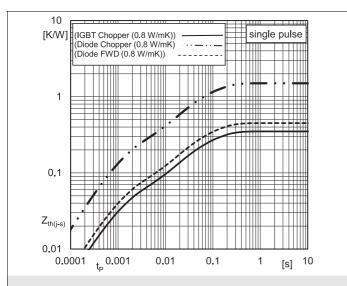


Fig. 9: Typ. transient thermal impedance

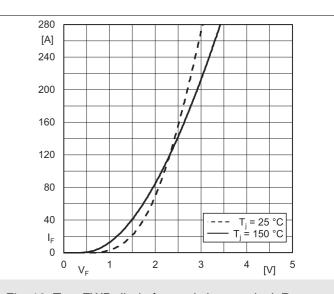


Fig. 10: Typ. FWD diode forward charact., incl. $R_{\text{CC'+EE'}}$

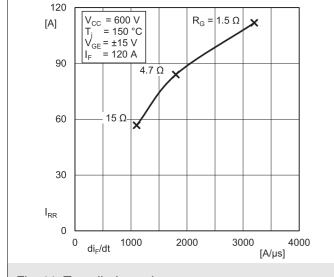


Fig. 11: Typ. diode peak reverse recovery current

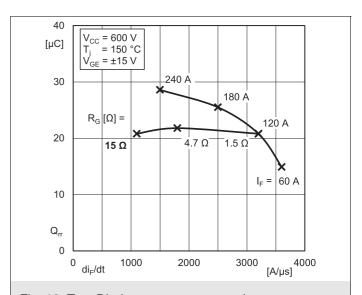
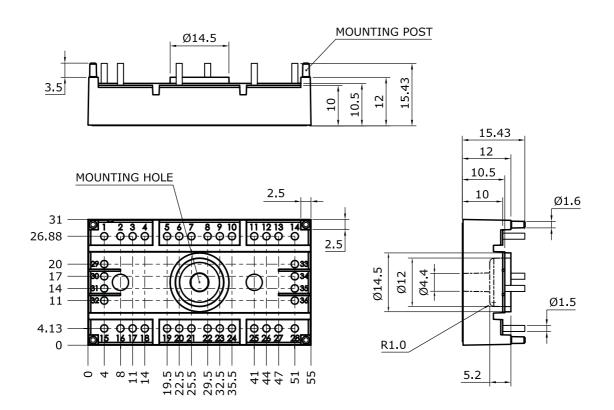


Fig. 12: Typ. Diode reverse recovery charge

Dimensions: mm

Tolerance system: ISO 2768-m



Suggested hole diameter for solder pins in the circuit board:

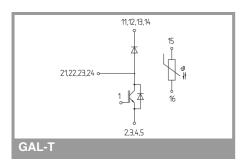
• 2.0 mm

Suggested hole diameter for the mounting post in the circuit board:

• 2.0 mm

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SEMITOP®3



This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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